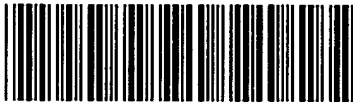


Search Notes

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10/776,760

Examiner

Than Nguyen

Applicant(s)/Patent under
Reexamination

BHATIA, SANDEEP

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West IEEE Inventor	8/18/2006	NTV